

Search Notes

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Examiner

J. Derek Rutten

Applicant(s)/Patent under
Reexamination

FUNK ET AL.

Art Unit

2192

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-PGPUB; USPAT; EPO; JPO; IBM_TDB; DERWENT) - see search history printout	5/21/2007	JDR